Notice of References Cited Application/Control No. 10/517,895 Examiner David Schindler Applicant(s)/Patent Under Reexamination INOUE, MASAHIRO Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0062459 A1	04-2004	Bochet, Alain	384/448
	В	US-			
	С	US			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	H	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			•

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.